

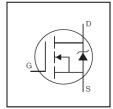
AUTOMOTIVE GRADE



HEXFET® Power MOSFET

Features

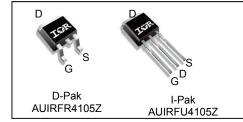
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- · Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}		55V
R _{DS(on)} max.		24.5mΩ
I _D		30A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Boss nort number	Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFU4105Z	I-Pak	Tube	75	AUIRFU4105Z
ALUDED44057 D. Dok		Tube	75	AUIRFR4105Z
AUIRFR4105Z	D-Pak	Tape and Reel Left	3000	AUIRFR4105ZTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless

•	•	. ,	
Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	30	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	21	Α
I _{DM}	Pulsed Drain Current ①	120	=
P _D @T _C = 25°C	Maximum Power Dissipation	48	W
	Linear Derating Factor	0.32	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	29	
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ®	46	- mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		3.12	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ∅		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

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^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.053		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		19	24.5	mΩ	V _{GS} = 10V, I _D = 18A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	16			S	V _{DS} = 15V, I _D = 18A ③
	Drain to Source Leakage Current			20	μA	$V_{DS} = 55V$, $V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			200	- Λ	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	nA	$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

-		_	-		
Total Gate Charge		18	27		I _D = 18A
Gate-to-Source Charge		5.3		nC	$V_{DS} = 44V$
Gate-to-Drain Charge		7.0			V _{GS} = 10V3
Turn-On Delay Time	—	10			$V_{DD} = 28V$
Rise Time		40		no	I _D = 18A
Turn-Off Delay Time		26		115	$R_G = 24.5\Omega$
Fall Time		24			V _{GS} = 10V3
Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Internal Source Inductance		7.5			from package and center of die contact
Input Capacitance		740			$V_{GS} = 0V$
Output Capacitance		140			$V_{DS} = 25V$
Reverse Transfer Capacitance		74		nΕ	f = 1.0MHz
Output Capacitance		450		рΓ	$V_{GS} = 0V$, $V_{DS} = 1.0V$ $f = 1.0MHz$
Output Capacitance		110			$V_{GS} = 0V$, $V_{DS} = 44V$ $f = 1.0MHz$
Effective Output Capacitance		180			V_{GS} = 0V, V_{DS} = 0V to 44V \oplus
	Gate-to-Source Charge Gate-to-Drain Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Drain Inductance Internal Source Inductance Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance	Gate-to-Source Charge ————————————————————————————————————	Gate-to-Source Charge — 5.3 Gate-to-Drain Charge — 7.0 Turn-On Delay Time — 10 Rise Time — 40 Turn-Off Delay Time — 26 Fall Time — 24 Internal Drain Inductance — 7.5 Input Capacitance — 740 Output Capacitance — 140 Reverse Transfer Capacitance — 74 Output Capacitance — 450 Output Capacitance — 450 Output Capacitance — 110	Gate-to-Source Charge — 5.3 — Gate-to-Drain Charge — 7.0 — Turn-On Delay Time — 10 — Rise Time — 40 — Turn-Off Delay Time — 26 — Fall Time — 24 — Internal Drain Inductance — 4.5 — Internal Source Inductance — 7.5 — Input Capacitance — 740 — Output Capacitance — 140 — Reverse Transfer Capacitance — 74 — Output Capacitance — 450 — Output Capacitance — 110 —	Gate-to-Source Charge — 5.3 — nC Gate-to-Drain Charge — 7.0 — Turn-On Delay Time — 10 — Rise Time — 40 — Turn-Off Delay Time — 26 — Fall Time — 24 — Internal Drain Inductance — 4.5 — Input Capacitance Inductance — 7.5 — Input Capacitance — 740 — Output Capacitance — 74 — Output Capacitance — 74 — Output Capacitance — 450 — Output Capacitance — 110 —

Diode Characteristics

21040 011414001101100						
	Parameter	Min.	Тур.	Max.	Units	Conditions
L	Continuous Source Current			30		MOSFET symbol
IS	(Body Diode)			30	_	showing the
	Pulsed Source Current			120	A	integral reverse
I _{SM}	(Body Diode) ①			120		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 18A, V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		19	29	ns	$T_J = 25^{\circ}C$, $I_F = 18A$, $V_{DD} = 28V$
Q _{rr}	Reverse Recovery Charge		14	21	nC	di/dt = 100A/µs③
t _{on}	Forward Turn-On Time	Intrinsi	turn-or	n time is	negligil	ble (turn-on is dominated by L _S +L _D)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.18mH, R_G = 25 Ω , I_{AS} = 18A, V_{GS} =10V.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 \otimes R₀ is measured at T_J approximately 90°C.



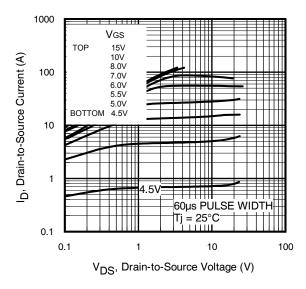


Fig. 1 Typical Output Characteristics

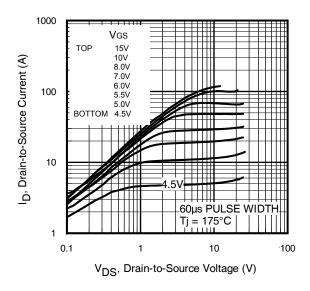


Fig. 2 Typical Output Characteristics

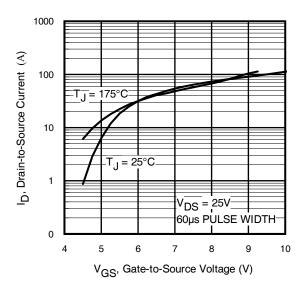


Fig. 3 Typical Transfer Characteristics

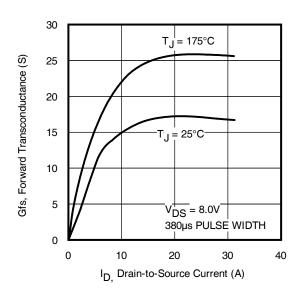


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



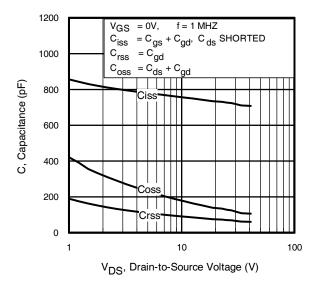


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

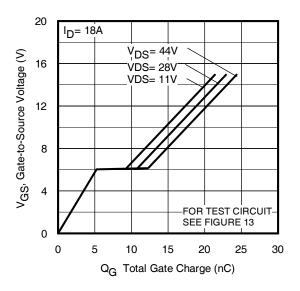


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

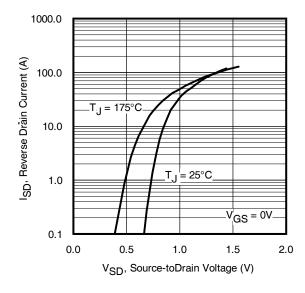


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

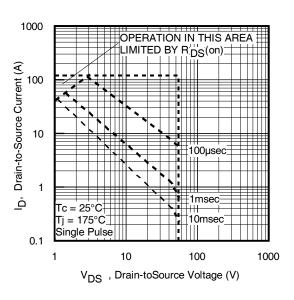
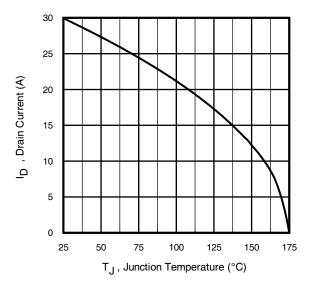


Fig 8. Maximum Safe Operating Area





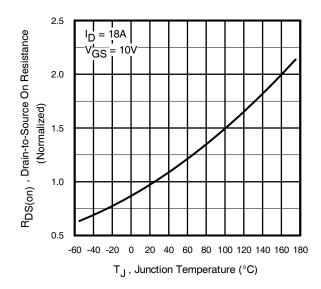


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

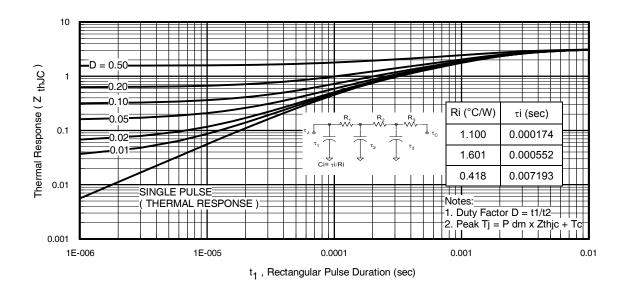


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



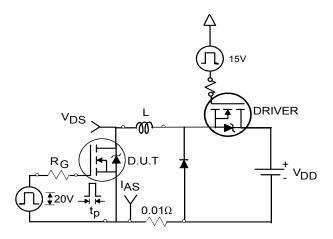


Fig 12a. Unclamped Inductive Test Circuit

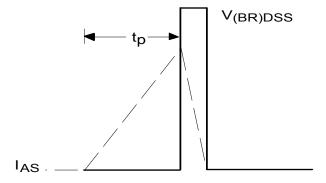


Fig 12b. Unclamped Inductive Waveforms

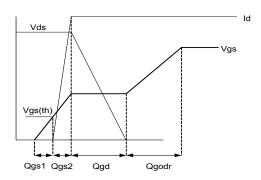


Fig 13a. Gate Charge Waveform

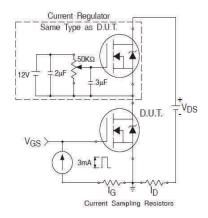


Fig 13b. Gate Charge Test Circuit

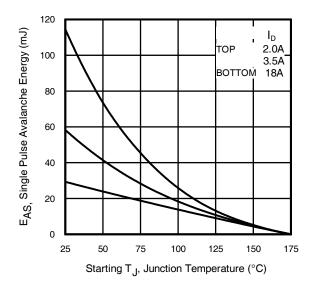


Fig 12c. Maximum Avalanche Energy vs. Drain Current

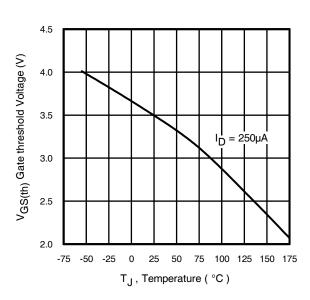


Fig 14. Threshold Voltage Vs. Temperature

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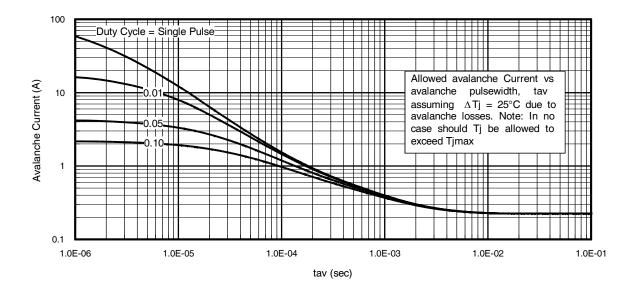


Fig 15. Typical Avalanche Current Vs. Pulse width

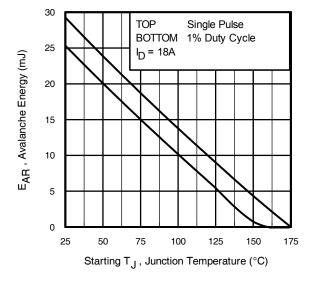


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

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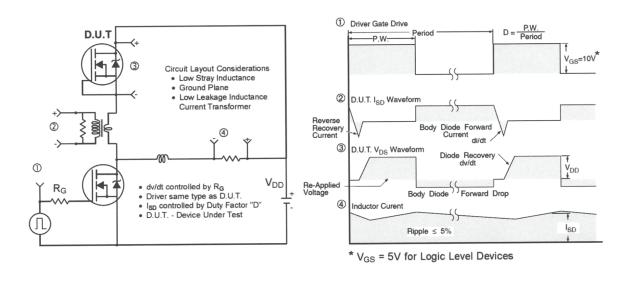


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

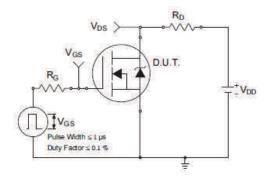


Fig 18a. Switching Time Test Circuit

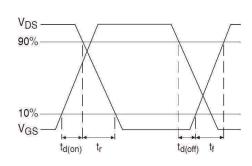
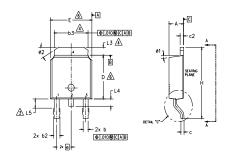


Fig 18b. Switching Time Waveforms

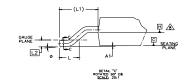
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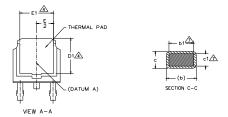


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 1 LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S			N		
M B O	MILLIM	ETERS	INC	HES	O T
O L	MIN.	MAX.	MIN.	MAX.	E S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108 REF.		
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	_	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10°	0,	10°	
ø1	0.	15*	0,	15*	
ø2	25*	35*	25*	35*	

LEAD ASSIGNMENTS

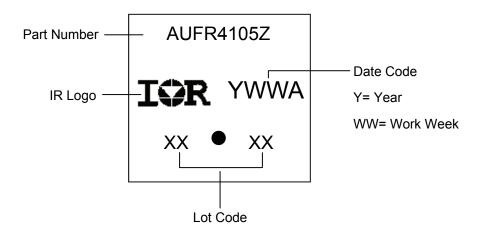
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE 4.- DRAIN
- 4. DIVAII

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

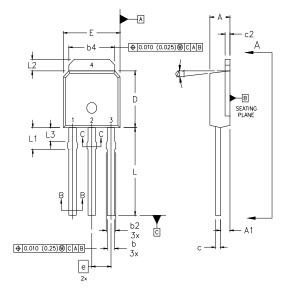
D-Pak (TO-252AA) Part Marking Information

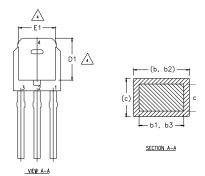


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- JIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
- 5 LEAD DIMENSION UNCONTROLLED IN L3.
- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
 OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
- B CONTROLLING DIMENSION : INCHES.

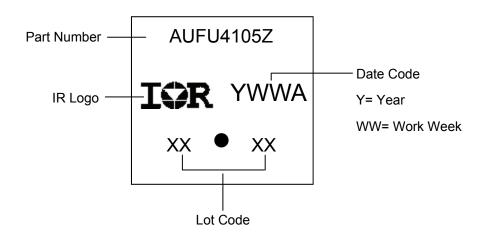
LEAD ASSIGNMENTS

ŀ	НE	X	F	Ε.	I
_					

1.- GATE
2.- DRAIN
3.- SOURCE
4.- DRAIN

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
А	2.18	2.39	0.086	.094	
A1	0.89	1.14	0.035	0.045	
b	0.64	0.89	0.025	0.035	
ь1	0.64	0.79	0.025	0.031	4
b2	0.76	1.14	0.030	0.045	
b3	0.76	1.04	0.030	0.041	
b4	5.00	5.46	0.195	0.215	4
С	0.46	0.61	0.018	0.024	
c1	0.41	0.56	0.016	0.022	
c2	.046	0.86	0.018	0.035	
D	5.97	6.22	0.235	0.245	3, 4
D1	5.21	-	0.205	-	4
E	6.35	6.73	0.250	0.265	3, 4
E1	4.32	-	0.170	-	4
e	2.	29	0.090 BSC		
L	8.89	9.60	0.350	0.380	
L1	1.91	2.29	0.075	0.090	
L2	0.89	1.27	0.035	0.050	4
L3	1,14	1.52	0.045	0.060	5
ø1	0*	15*	0*	15*	

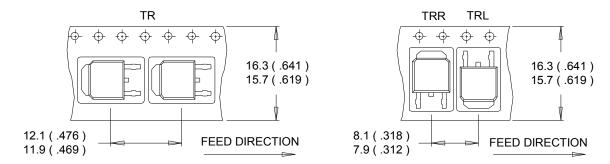
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

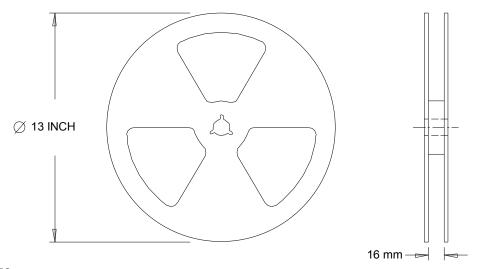


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

<u> </u>	don miorination					
Qualification Level		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		D-Pak	MCI 4			
		I-Pak	MSL1			
	Machine Medal	Class M2 (+/-200V) [†]				
	Machine Model	AEC-Q101-002				
FOD	Liverson Dady Madal	Class H1A (+/-500V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Observed Davis Madal	Class C5 (+/-1125V) [†]				
Charged Device Model		AEC-Q101-005				
RoHS Compliant			Yes			
		1				

[†] Highest passing voltage.

Revision History

Date	Comments
12/1/2015	Updated datasheet with corporate template
	Corrected ordering table on page 1.

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